

Search Notes

Application/Control No.

10/521,547

Examiner

Len Tran

Applicant(s)/Patent under
Reexamination

AOYAMA ET AL.

Art Unit

1725

SEARCHED

Class	Subclass	Date	Examiner
219	93	10/28/2006	LT
	119		
	120		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PALM	10/28/2006	LT